

FDB8132\_F085

# N-Channel PowerTrench® MOSFET **30 V, 110 A, 1.6 m**Ω

## **Features**

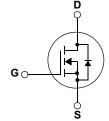
- Typ  $R_{DS(on)}$  = 1.4m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 80A
- Typ  $Q_{q(tot)}$  = 244nC at  $V_{GS}$  = 10V,  $I_D$  = 80A
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

## **Applications**

- Automotive Engine Control
- Powertrain Management
- Solenoid and Motor Drivers
- Integrated Starter/Alternator
- Primary Switch for 12V Systems







October 2014

**TO-263 FDB SERIES** 

For current package drawing, please refer to the Fairchild website at https://www.fairchildsemi.com/package-drawings/TO/TO263A02.pdf

## **MOSFET Maximum Ratings** T<sub>J</sub> = 25°C unless otherwise noted.

Symbol	Parameter		Ratings	Units	
$V_{DSS}$	Drain-to-Source Voltage		30	V	
$V_{GS}$	Gate-to-Source Voltage		±20	V	
	Drain Current - Continuous ( $V_{GS}$ =10) (Note 1) $T_C$ = 25°C		110	_	
ID	Pulsed Drain Current	T <sub>C</sub> = 25°C	See Figure 4	_ A	
E <sub>AS</sub>	Single-Pulse Avalanche Energy	(Note 2)	1434	mJ	
D	Power Dissipation		333	W	
$P_{D}$	Derate Above 25°C		2.22	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to + 175	°C	
$R_{\theta JC}$	Thermal Resistance, Junction to Case		0.45	°C/W	
$R_{\theta JA}$	Maximum Thermal Resistance, Junction to Ambient	(Note 3)	43	°C/W	

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB8132	FDB8132_F085	D2-PAK(TO-263)	330mm	24mm	800 units

- 1: Current is limited by bondwire configuration.
- 2: Starting  $T_J = 25^{\circ}C$ , L = 0.7mH,  $I_{AS} = 64A$ ,  $V_{DD} = 20V$  during inductor charging and  $V_{DD} = 0V$  during time in avalanche. 3:  $R_{\theta,JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

Units

Max.

Тур.

# **Electrical Characteristics** $T_J = 25^{\circ}\text{C}$ unless otherwise noted.

**Parameter** 

Off Characteristics								
B <sub>VDSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 250μA, \	V <sub>GS</sub> = 0V	30	-	-	V	
I <sub>DSS</sub> Drain-to-Source Leakage Current	Dunin to Course Leakers Comment	V <sub>DS</sub> =30V,	$T_{J} = 25^{\circ}C$	-	-	1	μΑ	
	$V_{GS} = 0V$	$T_J = 175^{\circ}C(Note 4)$	-	-	1	mA		
less	Gate-to-Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA	

**Test Conditions** 

Min.

## On Characteristics

Symbol

$V_{GS(th)}$	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$		2.0	2.6	4.0	V
r	r <sub>DS(on)</sub> Drain-to-Source On Resistance	I <sub>D</sub> = 80A,	$T_{J} = 25^{\circ}C$	-	1.4	1.6	$m\Omega$
DS(on)		V <sub>GS</sub> = 10V	$T_J = 175^{\circ}C(Note 4)$	-	2.3	2.7	mΩ

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V		-	13450	-	pF
C <sub>oss</sub>	Output Capacitance	$v_{DS} = 25v, v_{GS} = 100$	$V_{DS} = 25V, V_{GS} = 0V,$ - f = 1MHz		1740	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/2			1200	-	pF
$R_g$	Gate Resistance	f = 1MHz		-	1.1	-	Ω
$Q_{g(ToT)}$	Total Gate Charge at 10V	V <sub>GS</sub> = 0 to 10V	V <sub>DD</sub> = 24V	-	244	308	nC
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0$ to 2V	$V_{GS} = 0 \text{ to } 2V$ $I_D = 80A$		22.5	27	nC
$Q_{gs}$	Gate-to-Source Gate Charge			-	44	-	nC
$Q_{gd}$	Gate-to-Drain "Miller" Charge			-	64	-	nC

# **Switching Characteristics**

t <sub>on</sub>	Turn-On Time		-	-	172	ns
t <sub>d(on)</sub>	Turn-On Delay		-	44	-	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15V, I <sub>D</sub> = 80A,	-	82	-	ns
t <sub>d(off)</sub>	Turn-Off Delay	$V_{GS} = 10V, R_{GEN} = 6\Omega$	-	78	-	ns
t <sub>f</sub>	Fall Time		-	23	-	ns
t <sub>off</sub>	Turn-Off Time		-	-	121	ns

## **Drain-Source Diode Characteristics**

V	Source-Drain Diode Voltage	I <sub>SD</sub> = 80A, V <sub>GS</sub> = 0V	-	-	1.25	V
$V_{SD}$	Source-Drain blode voltage	$I_{SD} = 40A, V_{GS} = 0V$	-	1	1.2	V
t <sub>rr</sub>	Reverse-Recovery Time	$I_F = 80A$ , $dI_{SD}/dt = 100A/\mu s$ ,	-	67	71	ns
Q <sub>rr</sub>	Reverse-Recovery Charge	$V_{\rm DD}=24V$	-	95	106	nC

## Note:

4: The maximum value is specified by design at  $T_J$  = 175°C. Product is not tested to this condition in production.

# 

**Typical Characteristics** 

0

25

50

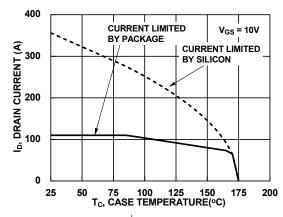


Figure 1. Normalized Power Dissipation vs. Case Temperature

75

100

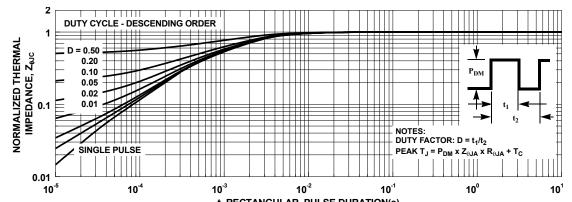
T<sub>C</sub>, CASE TEMPERATURE(°C)

125

150

Figure 2. Maximum Continuous Drain Current vs.

Case Temperature



t, RECTANGULAR PULSE DURATION(s)
Figure 3. Normalized Maximum Transient Thermal Impedance

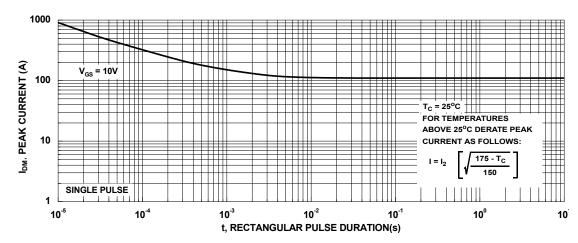


Figure 4. Peak Current Capability

# **Typical Characteristics**

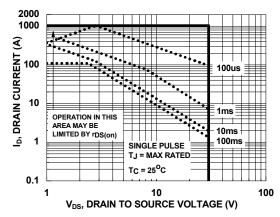
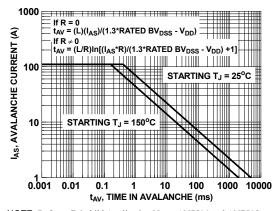


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching Capability

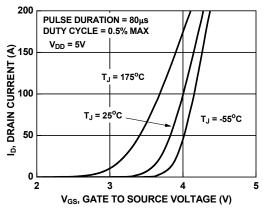


Figure 7. Transfer Characteristics

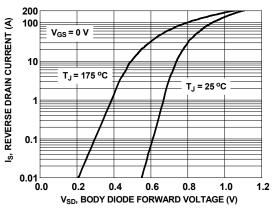


Figure 8. Forward Diode Characteristics

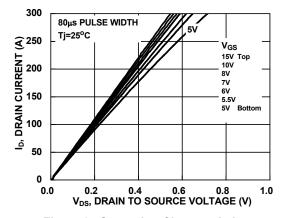


Figure 9. Saturation Characteristics

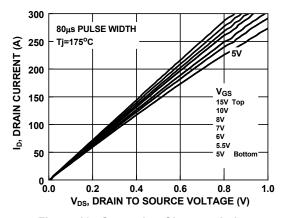


Figure 10. Saturation Characteristics

# **Typical Characteristics**

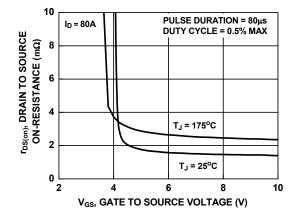


Figure 11. R<sub>dson</sub> vs. Gate Voltage

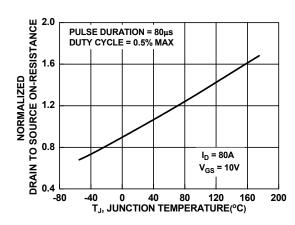


Figure 12. Normalized  $R_{dson}$  vs. Junction Temperature

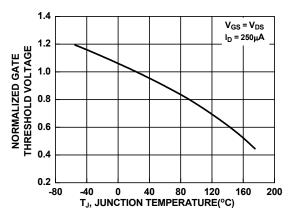


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

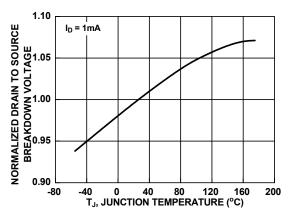


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

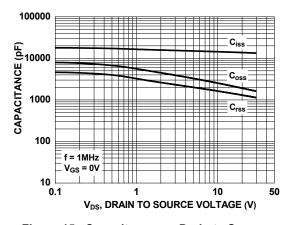


Figure 15. Capacitance vs. Drain to Source Voltage

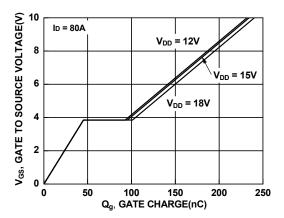


Figure 16. Gate Charge vs. Gate to Source Voltage





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Rev. 171